# Brammer Standard Company, Inc.

# **Certificate of Analysis**

## **BS 9811**

Certified Reference Material<sup>1</sup> for Custom 450 Stainless Steel Alloy (UNS Number \$45000)

	Certified Value <sup>2</sup>	Estimate of Uncertainty <sup>3</sup>	Certified Value <sup>2</sup>	Estimate of Ucertainty <sup>3</sup>					
Analysis listed as percent by weight									
С	0.027	0.002	Sn	0.004	0.001				
Mn	0.380	0.008	V	0.086	0.002				
Р	0.016	0.001	w	0.013	0.004				
S	0.0010	0.0004							
Si	0.36	0.012							
Cu	1.63	0.02							
Ni	6.55	0.05	Information	on Values <sup>4</sup>					
Cr	14.87	0.03	Al	0.003					
Мо	0.744	0.012	As	0.003					
Са	0.0014	0.0001	В	0.0003					
Co	0.055	0.003	0	0.0060					
N	0.0196	0.0008	Ti	0.003					
Nb	0.62	0.01							

<sup>&</sup>lt;sup>1</sup> Brammer Standard Company, Inc., is accredited to ISO Guide 34 as a Reference Material Producer to produce Certified Reference Materials by A2LA (Certificate Number 656.02)

See the following pages for more information.

Certificate Number 9811-032701p1

<sup>&</sup>lt;sup>2</sup> The certified value listed is the present best estimate of the true value based on the results of an interlaboratory testing program.

<sup>&</sup>lt;sup>3</sup> The uncertainties listed are based on value judgments of the material inhomogeneity and the 95% confidence interval. The half-width confidence interval C(95%) is shown on page 2.

<sup>&</sup>lt;sup>4</sup> Information values are not certified and are provided for information only.

BS 9811	Data listed as mass fraction expressed as percent.											981	9811-032701p2			
Analysis	*	С	*	Mn	*	Р	*	S	*	Si	*	Cu	*	Ni	*	Cr
1 2 3 4 5	0 0 0 0 0	0.0253 0.0266 0.0268 0.027 0.027 0.028 0.030	XRI XRI AES AIC AA MnI AIC AES	F 0.365 F 0.37 S 0.374 C 0.376 0.378 P 0.378 C 0.380 S 0.381 F 0.383	AI( MPI XRI XRI XRI AI( XRI AGI	C 0.015 H 0.015 F 0.0152 F 0.0155 F 0.0158 C 0.0159 F 0.016 A 0.0161	C C C C C C	0.0005 0.0005 0.00070 0.0010 0.0010 0.0013 0.0017	AIC XRE AES XRE AGA GSi GSi	0.340 0.349 0.354 0.354 0.354 0.354 0.358 0.359 0.365	XRI AIC XRI AES AIC XRI XRI AA	F 1.59 C 1.605 C 1.61 F 1.625 S 1.628 C 1.63 F 1.632 F 1.635 1.637	AIC XRI XRI XRI TNI GNI GNI AGX	C 6.463 F 6.489 F 6.50 F 6.50 L 6.52 L 6.534 L 6.54 K 6.55 F 6.553	TC: TC: AE: XR! AG: XR! AE: XR!	14.82 14.82 14.84 14.84 14.861 14.87 14.88 14.88 14.88
Average		0.0272	A10	0.392		0.0160		0.00096		0.3616		1.630	TNI	6.62  6.545		14.865
Std Dev		0.0015		0.0076		0.0007		0.00044		0.0149		0.019		0.047		0.031
Certified		0.027		0.380		0.016		0.0010		0.36		1.63		6.55		14.87
t		2.4469		2.1604		2.201		2.4469		2.2010		2.1788		2.1604		2.2281
C (95%)		0.0013		0.0044		0.0005		0.00041		0.0095		0.012		0.027		0.021
Analysis	*	Мо	*	Ca	*	Co	*	N 	*	Nb	*	Sn	*	V	*	W
1 2 3 4 5 6 7 8 9 10 11 12 13 14	GMO XRF AES AIC AGX AIC XRF AES XRF MMT AIC	0.725 0.731 0.735 0.737 0.739 0.741 0.741 0.746 0.747 0.747 0.768 0.770	AAA AIC AIC AGA AES AIC AIC	0.0012 0.0013 0.0013 0.0014 0.0014 0.0014 0.0015 0.0015	AIC XRF AIC AGX XRF AAA AES XRF AES M5 AIC XRF	0.049 0.050 0.053 0.054 0.055 0.055 0.056 0.056 0.056 0.0562 0.0562	FU TN FU FU FU FU FU	0.0186 0.0186 0.0188 0.0195 0.01979 0.020 0.0202	XRF AIC AIC MNA AIC AGX XRF MNR AIC AES AES XRF AIC	0.597 0.604 0.609 0.614 0.615 0.619 0.623 0.624 0.624 0.626 0.629 0.63	AIC AES AIM AIH AIC MSn AIC AES AAG AGA AIM	0.003 0.00305 0.0032 0.0033 0.0033 0.0036 0.0039 0.004 0.0040 0.0040	XRF AIC AGA MVE XRF AES AIC XRF AIC AES XRF AAA	0.082 0.0845 0.085 0.085 0.085 0.085 0.085 0.086 0.086 0.086 0.087	AIC XRF AIC AIC MWC XRF AGA XRF AIM AIC AIC	0.007 0.008 0.0088 0.0093 0.0100 0.015 0.015 0.015 0.0164 0.017
Average		0.7439		0.00140		0.0547		0.01959		0.6191		0.0038		0.0859		0.0126
Std Dev		0.0134		0.00012		0.0030		0.00091		0.0104		0.0009		0.0022		0.0039
Certified		0.744		0.0014		0.055		0.0196		0.62		0.004		0.086		0.013
t 		2.201		2.306		2.1788		2.3646		2.1604		2.2281		2.201		2.2281
C(95%)		0.0085		0.00009		0.0018		0.0008		0.0060		0.0006		0.0014		0.0026
 Analysis	*	 Al	*	As	*	В	*	0	*	Ti	*	' Methods	of ana	ılysis listed	l on pa	ige 3
1 2 3 4	AES AES	0.005	AES		AES	3 0.0002 3 0.00031	FU FU FU	0.0056 0.0060 0.0060 0.00626	XRE XRE	0.004						
Average		0.0028		0.0028		0.00026		0.0060		0.0034						
Std Dev		0.0020		0.0004		0.00008		0.0003		0.0014						
Certified		(0.003)				(0.0003)		(0.0060)		(0.003)						

Data in parentheses are not certified but are provided for information only.

 $C(95\%) = (t \times sd)/n$  The half-width confidence interval, where t is the appropriate Student's t value, sd is the interlaboratory standard deviation, and n is the number of acceptable mean values. For further information regarding the confidence interval for the certified value see ISO Guide 35:1989 section 4.

### **Methods of Analysis**

Code	Element	Method
AA		Flame Atomic Absorption Spectrometry
AAA		Flame Atomic Absorption - standard addition method
AAG		Electro-thermal atomization (graphite furnace) Atomic Absorption Spectrometry
AES		AES - Spark Source Optical Emission Spectrometry
AGA		AES - Spark Source and Glow Discharge Spectrometry average
AGX		Glow Discharge and X-Ray Fluorescence Spectrometry average
AIC		AES - ICP -Inductively Coupled Plasma Spectrometry
AIH		AES - ICP -Inductively Coupled Plasma Spectrometry after hydride generation
AIM		AES - ICP Mass Spectrometry addition method
C	C, S	Combustion-Infrared Absorption (ASTM E 1019) traceable to CRMs
FU	N, O	Inert gas Fusion Method (ASTM E 1019) traceble to CRMs
GMo	Mo	Gravimetry, Benzolnoxime
GNi	Ni	Dimethylglyoxime gravimetric
GSi	Si	Gravimetry with perchloric acid
IC	S	Ion chrometography
M5	Co	MAS - 5-Cl-PADAB spectrophotometric
MCB	Cu	MAS - Bicyclohexane oxalyldihydrazone photometric
MCT	Cu	MAS - Tetraethylthiuram disulphide
MMT	Mo	MAS - Thiocyanate photometric
MNA	Nb	MAS - Absorptionmetric determination method with 4-(2-pyridylazo)-Resorcinol
MnP	Mn	MAS - Periodate oxidation
MNR	Nb	MAS - PAR photometric
MPH	P	MAS - Heteropoly molybdenum blue photometric
MPN	P	MAS - Butylc alcohol-trichloromethane extraction photometric
MSn	Sn	MAS - Phenylfluorone photometric
MVE	V	MAS - n-benzoyl phenylhydroxylamine extraction photometric
MWC	W	MAS - Chlorpromazine hydrochloride sodium thiocyanate - tri-chloromethane extraction
TCr	Cr	Persulfate oxidation, ferrous sulfate titrimetric
TNi	Ni	EDTA titration
XRF		X-Ray Fluorescence spectrometry

AES = Atomic Emission Spectrom etry

MAS = M olecular Absorption Spectrometry (photometric, spectrophotometric methods)

#### Co-operating Laboratories: The co-operating laboratories were:

#### Laboratory

Allvac, Lockport, New York
Allvac, Monroe, North Carolina
ANAREM, Prague, Czech Republic
Brammer Standard Co., Inc., Houston, Texas
China National Analysis Center for Iron and Steel, Beijing, China
Crucible Specialty Steel, Syracuse, New York
J. Dirats and Co., Inc., Westfield, Massachusetts
IncoTest, Huntington, West Virginia
LECO Corporation, St. Joseph, Michigan

Shiva Analyticals (India) Ltd., Hoskote, Bangalore, India VHG Laboratories, Inc., Manchester, New Hampshire

#### Laboratory contact

Thomas Herdlein
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Prof. Wang Haizhou
William Mastroe
Eric E. Dirats
Melissa G. Staley
Dennis Lawrenz
Dr. T. V. Ramakrishna
Julie M. McIntosh

Additional analytical data: This material was used as an unknown test specimen number 9811 in a nationally recognized Proficiency Testing Program (PTP) for low-alloy steel. Most of the participating laboratories used one or more of the ASTM Standard Test Methods E 327, E 572, E 1019, and E 1086. The PTP data was not used in calculating the certified values listed on pages 1 and 2. The data shown below are the results from the PTP.

Combustion Instrument Analysis using ASTM Standard Test Method E 1019

	C	S	N	O
Number of Labs	26	23	19	18
Grand Average	0.0281	0.0008	0.0194	0.0069
Standard Deviation	0.0026	0.0004	0.0007	0.0010

Optical Emission Spectrometric Analysis using ASTM Standard Test Method E 1086

	C	Mn	P	S	Si	Cu	Ni
Number of Labs Grand Average Standard Deviation	18 0.0287 0.0029	16 0.3815 0.0077	17 0.0158 0.0017	14 0.0012 0.0006	18 0.3689 0.0167	17 1.6457 0.0250	16 6.4945 0.0763
	Cr	Mo	Co	V	Nb		
Number of Labs Grand Average Standard Deviation	16 14.8646 0.0951	18 0.7474 0.0176	8 0.0572 0.0034	6 0.0876 0.0034	5 0.6306 0.0243		

Optical Emission Spectrometric Analysis using ASTM Standard Test Method E 327

	Mn	Cu	Ni	Cr	Si
Number of Labs	4	4	4	4	4
Grand Average	0.3820	1.6635	6.5768	14.9113	0.3583
Standard Deviation	0.0053	0.0386	0.1213	0.1451	0.0129

X-ray Emission Spectrometric Analysis using ASTM Standard Test Method E 572

	Mn	P	Si	Cu	Ni	Cr	Mo	V	Co	Nb
Number of Labs		•	O	13	14	14	14	7	13	14
Grand Average	0.3709	0.0158	0.3586	1.6272	6.5141	14.8857	0.7361	0.0874	0.0555	0.6128
Standard Deviation	0.0136	0.0012	0.0176	0.0231	0.0292	0.0694	0.0158	0.0059	0.0064	0.0131

**Certification Process**: The requirements of ISO Guide 31, ISO Guide 34, ISO Guide 35, and ASTM Standard Guides E 1724 and E 1831 were followed for the preparation of this reference material and certificate of analysis. This is a Certified Reference Material as defined by ISO Guide 30.

**Analysis**: Chemical analyses were made on chips prepared by a lathe from the certified portion of the discs in accordance with ASTM Standard Practice E 1806. The laboratories participating in the testing normally followed the requirements of ISO Guide 25 and/or ISO Standard 17025. Individual values listed on page 2 are the average of each analyst's results. Methods of analysis are listed on page 3.

**Outliers:** Some outlying data was excluded from the data listed on page 2 due to technical assessment of the cooperating laboratories and statistical evaluation.

**Traceability:** The following Certified Reference Materials were used to validate the analytical data listed on page 2: SRM 15h, 32b, 126c, 131f, 166b, 343a, 345, 3103a, 3107, 3109a, 3161a; ECRM 284-1, 289-1, 295-1; BS CSN-1.

**Homogene ity**: This Certified Reference Material was tested for homogeneity using ASTM Standard Method E 826 and found acceptable. It was also examined by optical emission spectrometry using ASTM Standard Test Method E 1086 and found to be compatible with the following Reference Materials: SRM C1151, 1219, C1289, C2400; BS 17-4PH, 95, 95A, 96.

Validity statement: ISO Guide 31 states that the certification should contain an expiration date for all materials where instability has been demonstrated or is considered possible, after which the certified value is no longer guaranteed by the certifying body. Whereas this material is in a solid form and stable, no expiration date is specified.

**Source**: This material was produced by Carpenter Technology Corporation, Reading, Pennsylvania It was melted by an electric arc furnace, bottom poured into ingots, hot rolled, and finished with a normalized heat treatment.

Form: This Certified Reference Material is in the form of a disc, approximately 38 mm in diameter and 12 mm thick.

**Use:** This Certified Reference Material is intended for use in optical emission and x-ray spectrometric methods of analysis. Refer to ISO Guide 33 for information about the use of Reference Materials.

Certified area: The entire depth of the disc may be used.

**Caution:** As with any bar material, avoid optical emission spectrometric burns in the center of the disc (5 mm radius), as some segregation may be present.

**Sample Preparation**: For best analytical results, use the same method for preparing the analytical surface on all reference materials as you use for production specimens. Avoid overheating the disc during surface preparation.

Certificate Number: The unique identification number for this certificate of analysis is 9811-032701-px, where x indicates the page number. Refer to future Brammer Standard Company catalogs for information on any revisions to this or other Brammer Standard reference materials. You may also obtain information on revisions of certificates from the internet at brammerstandard.com.

**Safety Notice:** A Material Safety Data Sheet (MSDS) is not required for this material. This material will not release or otherwise result in exposure to a hazardous chemical under normal conditions of use. Inquiries concerning this Reference Material should be directed to:

Brammer Standard Co 14603 Benfer Road	o., Inc.	Phone:	(281) 440-9396	web	brammerstandard.com
Houston, Texas 770	69-2895 USA	Fax:	(281) 440-4432	e-mail	bramstan@netropolis.net
Certified by:		o	on March 27, 2001.		
G. R.	. Brammer				

Brammer Standard Company, Inc., is accredited to ISO Guide 34 as a Reference Material Producer for the production of Certified Reference Materials and Reference Materials by A2LA (Certificate Number 656.02) The scope of accreditation is listed on the website: www.brammerstandard.com

By Certificate Number 10539, the Quality System of Brammer Standard Company, Inc., is registered to ISO 9002:1994 by National Quality Assurance, U.S.A.

Brammer Standard Company's Chemical Laboratory is accredited to ISO Guide 25 by A2LA. (Certificate Number 656.01)

#### References:

ASTM documents available from ASTM, 100 Barr Harbor Drive, West Conshohocken, PA 19428-2959, Telephone: 610-832-9500 Fax: 610-832-9555 e-mail: service@astm.org Website: www.astm.org

E 327 - 94 Standard Test Method for Optical Emission Spectrometric Analysis of Stainless Type 18-8 Steels by the Point-to-Plane Technique

E 572 - 94 Standard Test Method for X-Ray Emissioin Spectrometric Analysis of Stainless Steel

E 826 - 85 (Reapproved 1996) Standard Practice for Testing Homogeneity of Materials for the Development of Reference Materials

E 1019 - 2000 Standard Test Methods for Determination of Carbon, Sulfur, Nitrogen, and Oxygen in Steel and in Iron, Nickel, and Cobalt Alloys

E 1086 - 94 Standard Test Method for Optical Emission Vacuum Spectrometric Analysis of Stainless Steel by the Point-to-Plane Excitation Technique

E 1724 - 95 Standard Guide for Testing and Certification of Metal and Metal-Related Reference Materials

E 1806 - 96 Standard Practice for Sampling Steel and Iron for Determination of Chemical Composition

E 1831 - 96 Standard Guide for Preparing Certificates for Reference Materials Relating to Chemical Composition of Metals, Ores, and Related Materials.

ISO Guides available from Global Engineering - www.global.ihs.com

ISO Standard 17025 (First edition, 1999), General requirements for the competence of calibration and testing laboratories.

ISO Guide 25 (Third edition, 1990), General requirements for the competence of calibration and testing laboratories.

ISO Guide 30 (Second edition, 1991), Terms and definitions used in connection with reference materials.

ISO Guide 31 (Second edition, 2000), Reference materials -Contents of certificates and labels.

ISO Guide 33 (Second edition, 2000), Uses of certified reference materials.

ISO Guide 34 (Second edition, 2000), General requirements for the competence of reference material producers.

ISO Guide 35 (Second edition, 1989), Certification of reference materials - General and statistical principles.

Other useful documents available from NIST, U.S. Department of Commerce, Gaithersburg, MD 20899.

NIST Special Publication 260-100, Handbook for SRM Users

NIST Special Publication 829, Use of NIST Standard Reference Materials for Decisions on Performance of Analytical Chemical Methods and Laboratories